



US011568812B2

(12) **United States Patent**  
**Iwauchi et al.**

(10) **Patent No.:** **US 11,568,812 B2**  
(45) **Date of Patent:** **Jan. 31, 2023**

(54) **DISPLAY DEVICE AND DISPLAY DEVICE DRIVING METHOD**

FOREIGN PATENT DOCUMENTS

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English translation of JP-201609939 printed from Search May 19, 2022, 12 pages (Year: 2016).\*

(\*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 0 days.

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(21) Appl. No.: **17/406,433**

(22) Filed: **Aug. 19, 2021**

(57) **ABSTRACT**

(65) **Prior Publication Data**

US 2022/0068204 A1 Mar. 3, 2022

A display device includes: a luminance converter which converts input gradation value into a corresponding target luminance value; a luminance correction calculator which calculates output gradation value from the target luminance value and calculates a corrected luminance value from the output gradation value, using an efficiency residual ratio which is an index representing the light-emitting element deterioration degree; a current stress calculator which converts current stress amount on the light-emitting element calculated from the corrected luminance value into current stress amount when reference current flows through the light-emitting element, and calculates the accumulated current stress amount; a temperature stress calculator which converts temperature stress amount on the light-emitting element under environmental temperature into temperature stress amount on the light-emitting element under reference temperature, and calculates the accumulated current stress amount; and an efficiency residual ratio calculator which updates the efficiency residual ratio, using the accumulated current and temperature stress amounts.

(30) **Foreign Application Priority Data**

Sep. 3, 2020 (JP) ..... JP2020-148311

(51) **Int. Cl.**  
**G09G 3/3233** (2016.01)

(52) **U.S. Cl.**  
CPC ... **G09G 3/3233** (2013.01); **G09G 2300/0819** (2013.01); **G09G 2320/0233** (2013.01);  
(Continued)

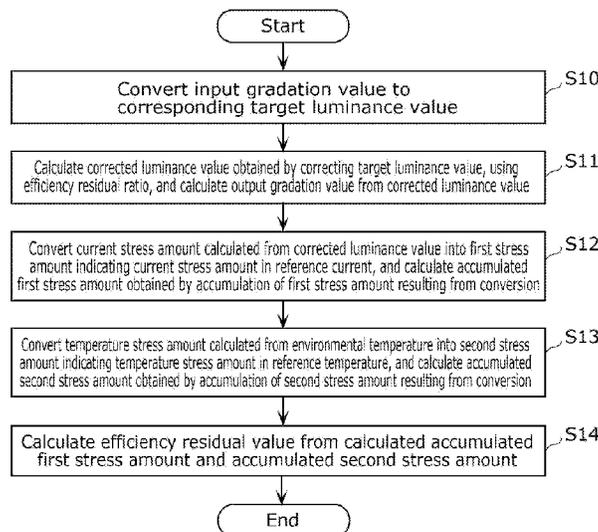
(58) **Field of Classification Search**  
None  
See application file for complete search history.

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**10 Claims, 11 Drawing Sheets**



(52) **U.S. Cl.**

CPC ..... G09G 2320/041 (2013.01); G09G  
2320/043 (2013.01); G09G 2320/045  
(2013.01); G09G 2320/048 (2013.01); G09G  
2360/16 (2013.01)

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FIG. 1

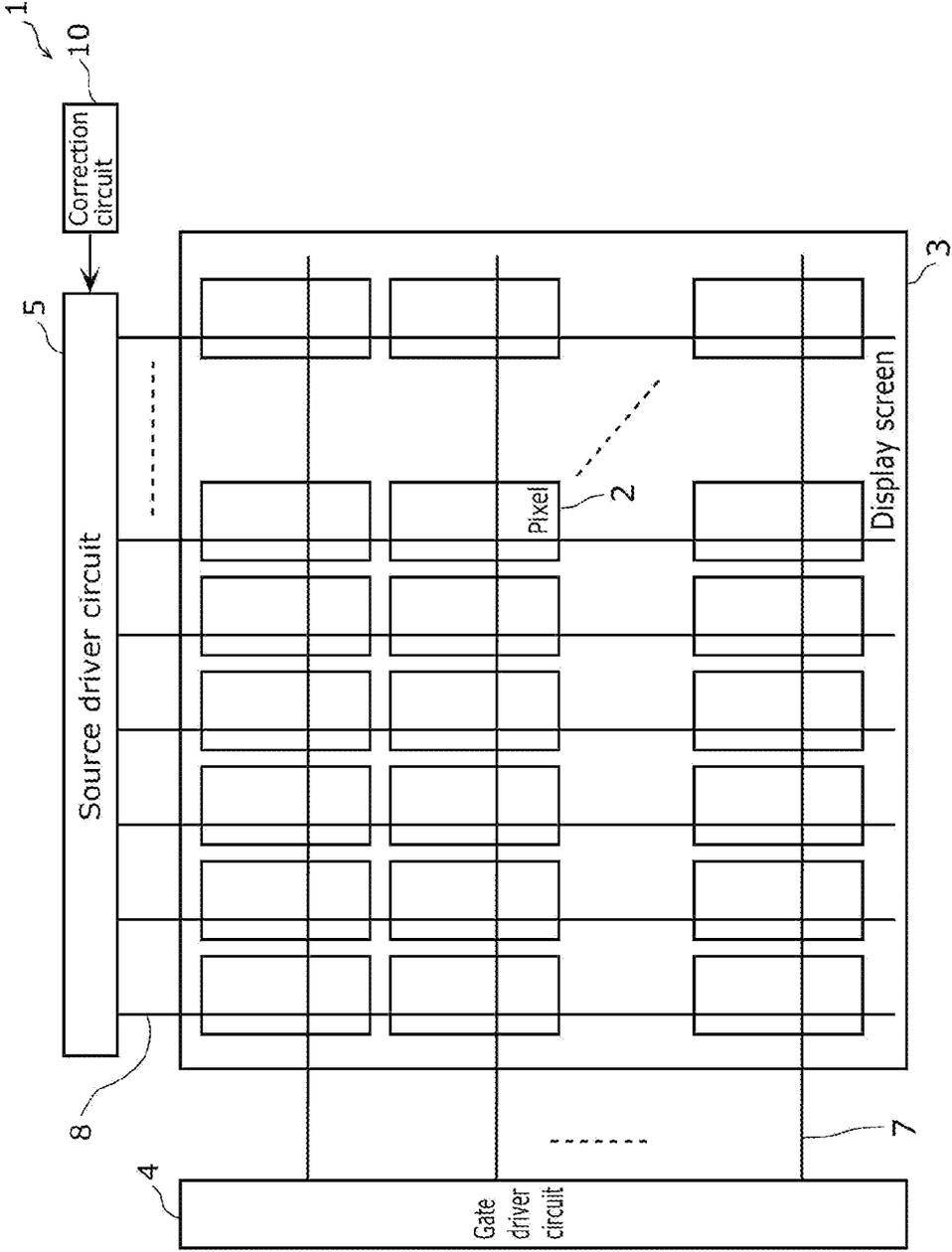


FIG. 2

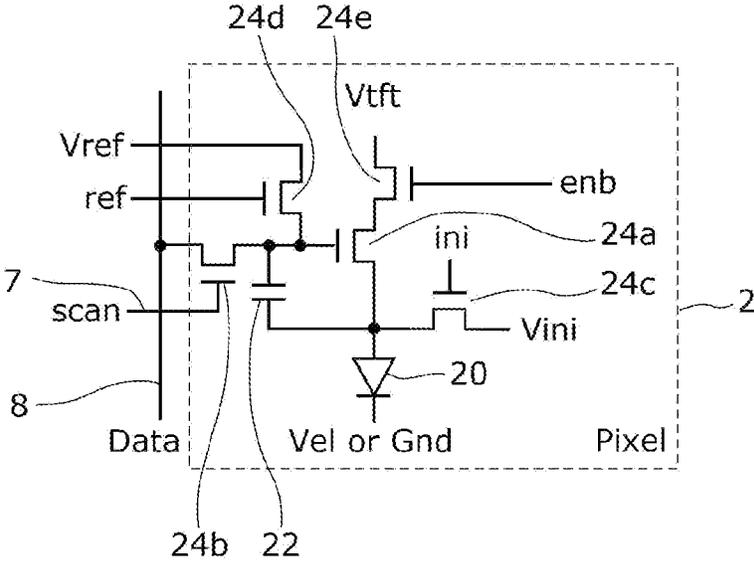


FIG. 3

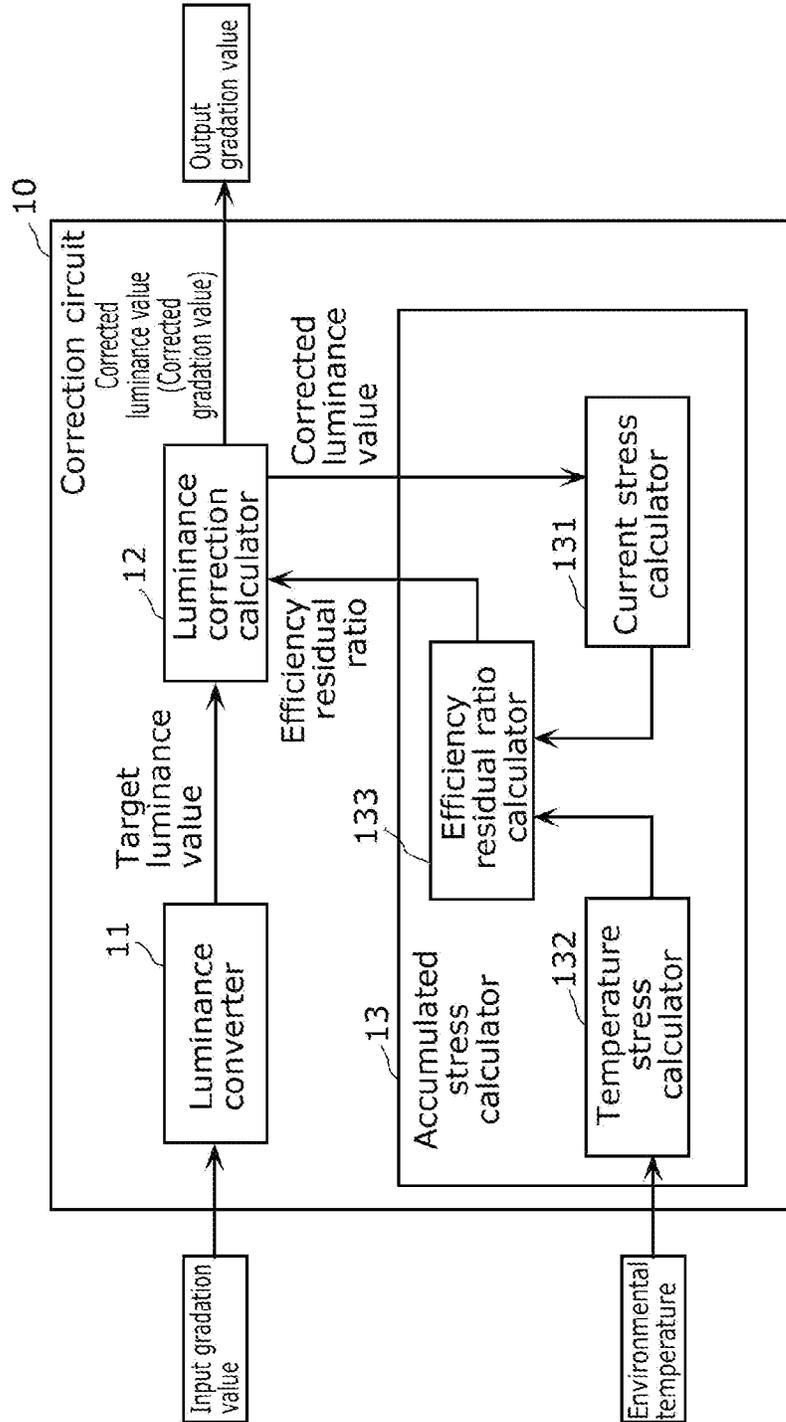


FIG. 4

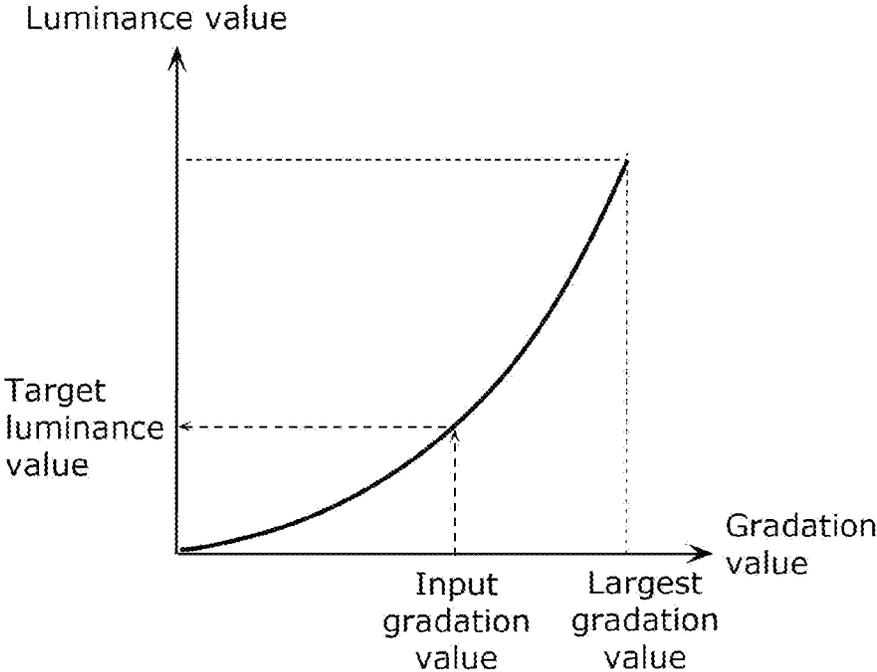


FIG. 5A

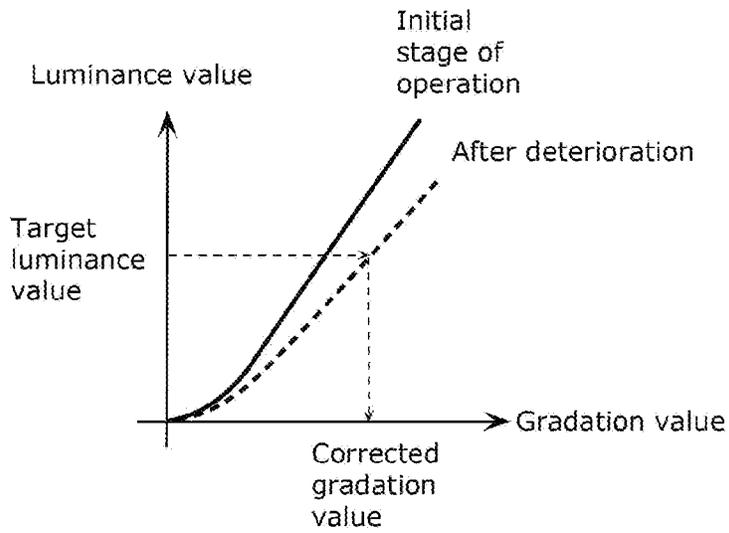


FIG. 5B

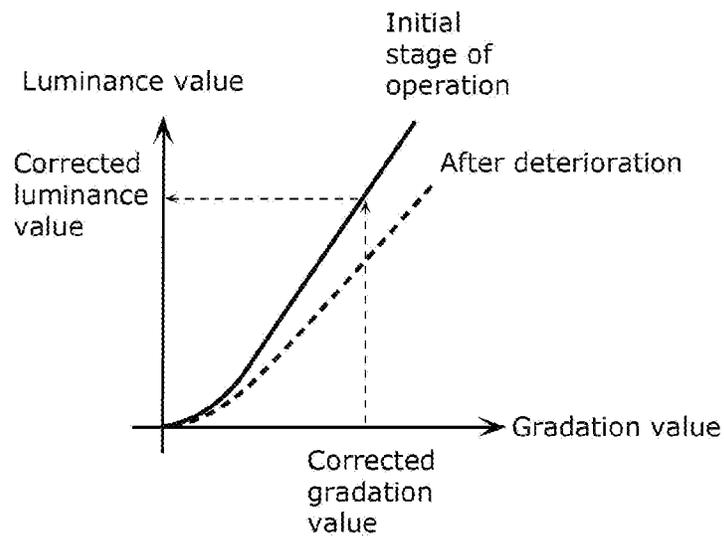


FIG. 6

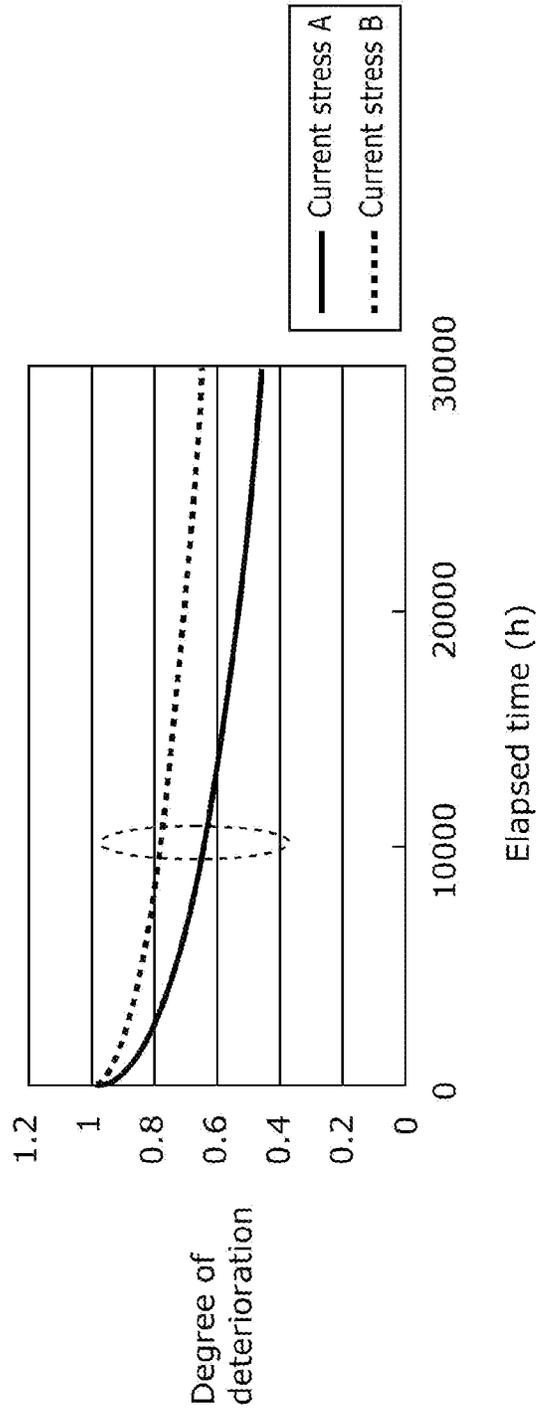


FIG. 7A

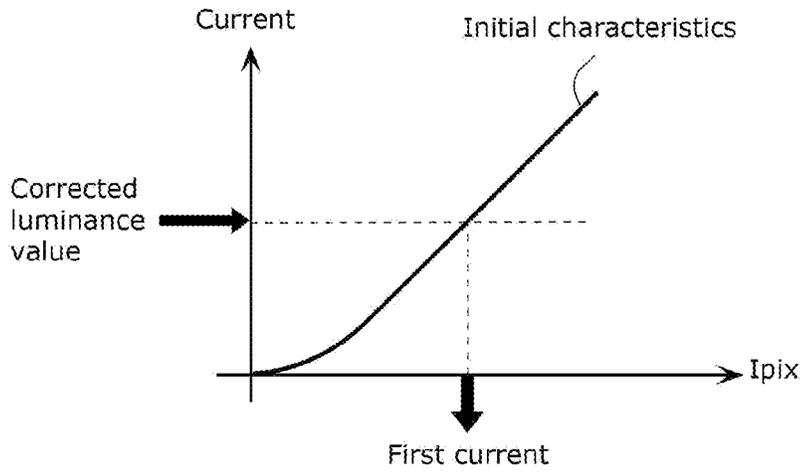


FIG. 7B

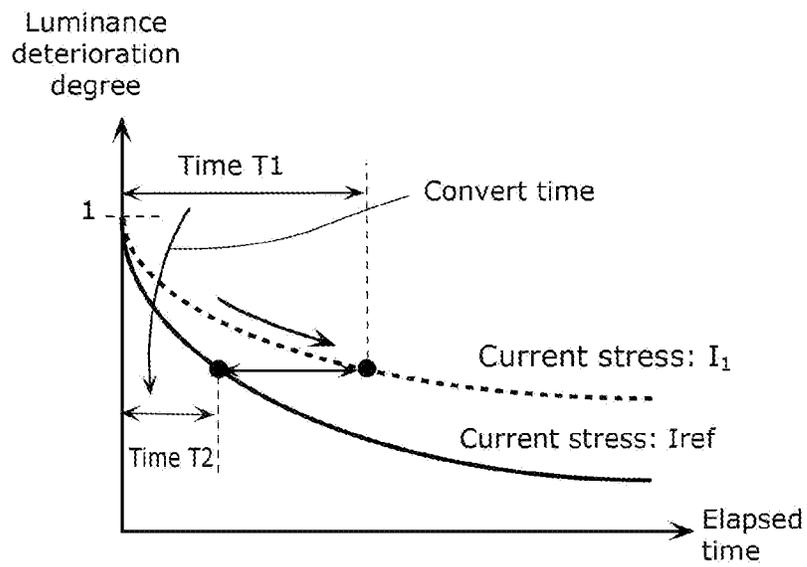


FIG. 8

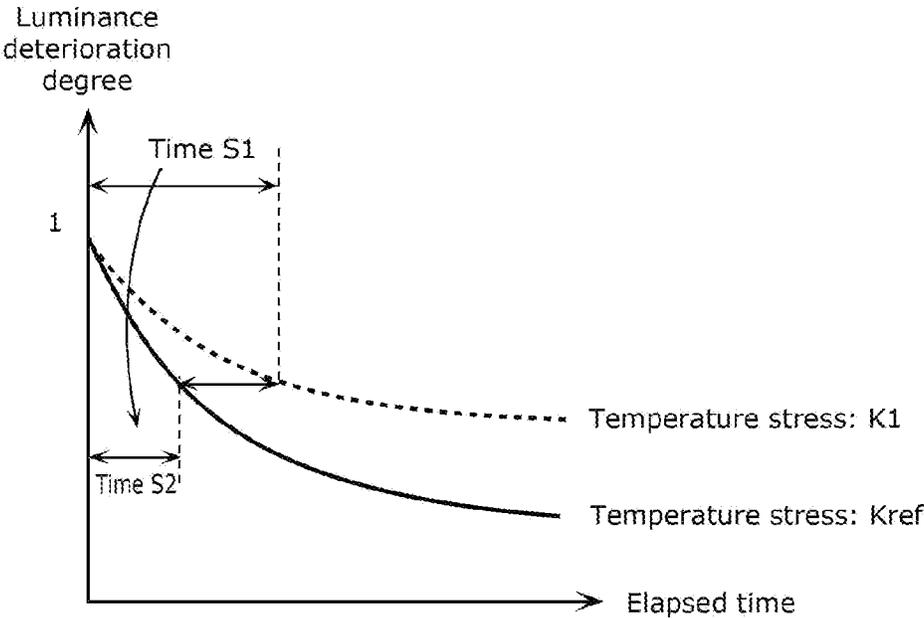


FIG. 9A

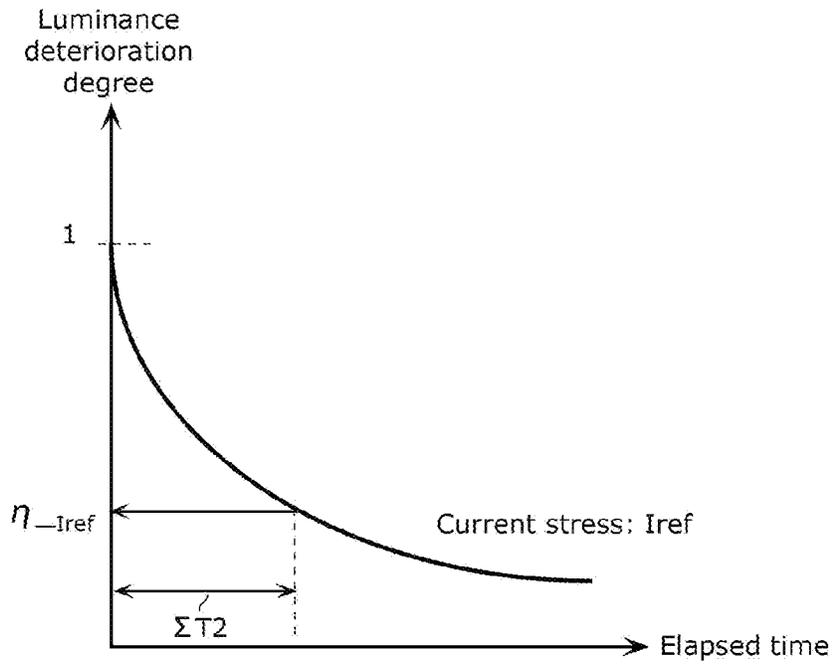


FIG. 9B

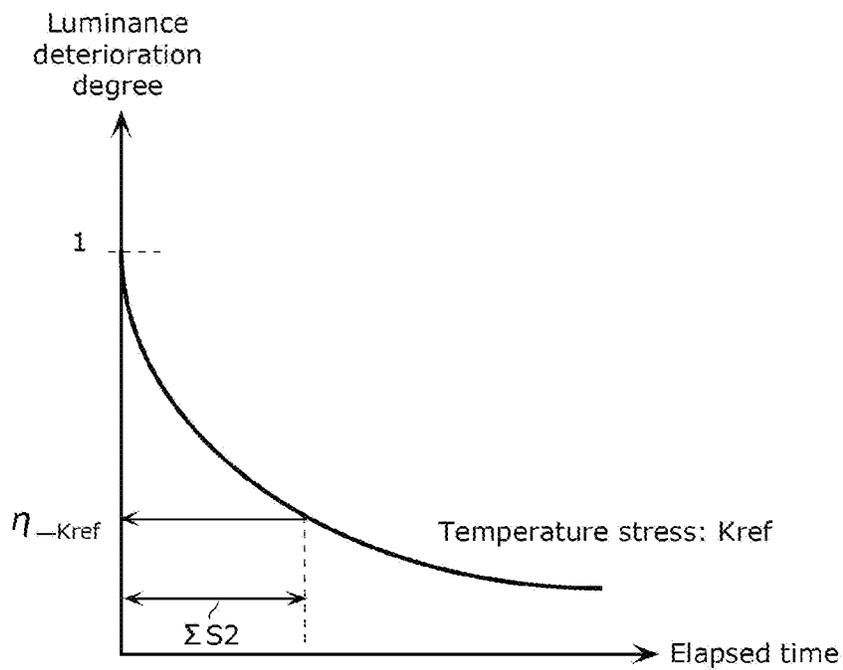


FIG. 10

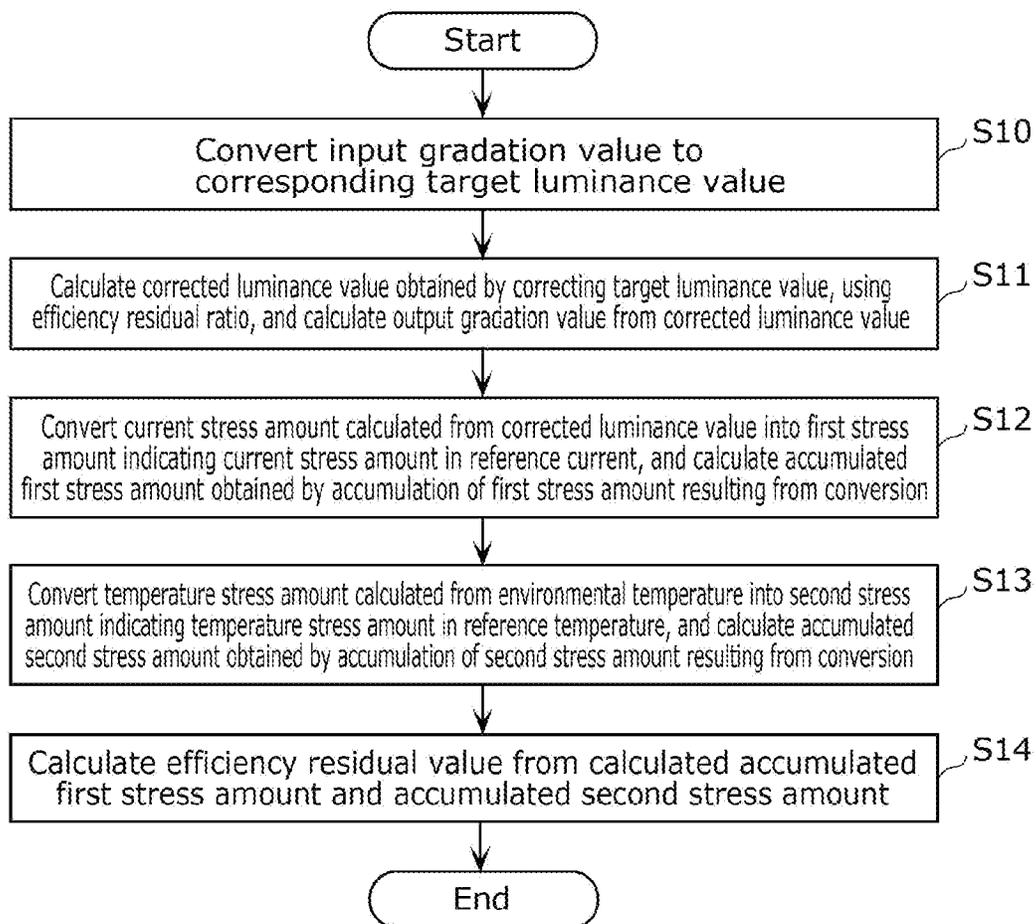
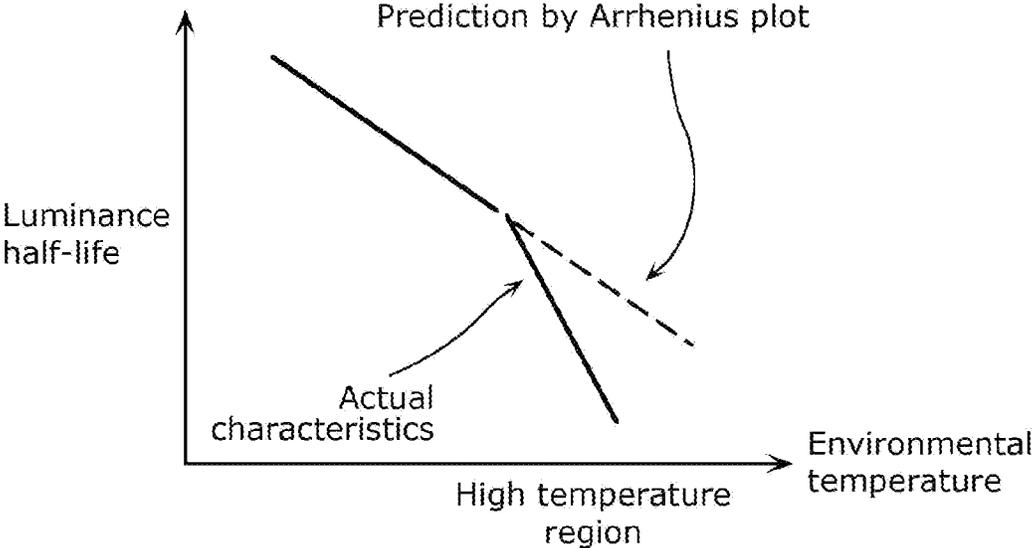


FIG. 11



**DISPLAY DEVICE AND DISPLAY DEVICE DRIVING METHOD**

**CROSS REFERENCE TO RELATED APPLICATION**

The present application is based on and claims priority of Japanese Patent Application No. 2020-148311 filed on Sep. 3, 2020. The entire disclosure of the above-identified application, including the specification, drawings and claims is incorporated herein by reference in its entirety.

**FIELD**

The present disclosure relates to display devices and display device driving methods.

**BACKGROUND**

It is known that, in luminescent elements such as organic electroluminescent (EL) elements, the light-emitting layer included in the luminescent element deteriorates according to the light-emission amount, the light-emission time (duration), and the temperature.

When luminance degradation due to deterioration of the light-emitting layer occurs, there are instances where, for example, display unevenness occurs in the display, such as when burn-in phenomena such as residual images or color fade-out occur, or color drift in images displayed on the display occurs, or luminance in a portion of the display deteriorates.

In order to solve such problems, a technique of reducing display unevenness by correcting a video signal has been disclosed (for example, see Patent Literature (PTL) 1).

**CITATION LIST**

**Patent Literature**

PTL 1: Japanese Unexamined Patent Application Publication No. 2016-109939

**SUMMARY**

**Technical Problem**

However, the aforementioned conventional technique does not take into consideration the case of operating a display in a relatively high temperature environment such as when the display is provided in a vehicle, and the like. For this reason, when operating the display under stress caused by environmental temperature such as when operating in a high temperature environment, even when the video signal is corrected according to the aforementioned conventional technique, sufficient correction precision cannot be obtained, and, as a result, correction error occurs, and there is the risk that display unevenness may occur in the display.

The present disclosure is conceived in view of the above-described circumstances and has as an object to provide a display device and a display device driving method which are capable of reducing display unevenness even when under stress caused by environmental temperature.

**Solution to Problem**

A display device according to an aspect of the present disclosure is a display device which includes a display

screen in which pixels are arranged in a matrix, each of the pixels including a light-emitting element, the display device including: a correction circuit which corrects an input gradation value indicated by a luminance signal included in a video signal, wherein the correction circuit includes: a luminance converter which converts the input gradation value into a target luminance value corresponding to the input gradation value; a correction calculator which calculates an output gradation value from the target luminance value using an efficiency residual ratio which is an index representing a degree of deterioration of the light-emitting element, and calculates a corrected luminance value from the output gradation value, the output gradation value being obtained by correcting the input gradation value, the efficiency residual ratio indicating a residual ratio of light emission efficiency of the light-emitting element, the corrected luminance value being obtained by correcting the target luminance value; a current stress calculator which converts a current stress amount on the light-emitting element that is calculated from the corrected luminance value into a first stress amount indicating a current stress amount when a reference current flows through the light-emitting element, and calculates an accumulated first stress amount obtained by accumulating the first stress amount resulting from the conversion; a temperature stress calculator which converts a temperature stress amount on the light-emitting element under environmental temperature into a second stress amount indicating a temperature stress amount on the light-emitting element under a reference temperature, and calculates an accumulated second stress amount obtained by accumulating the second stress amount resulting from the conversion; and an efficiency residual ratio calculator which updates the efficiency residual ratio, using the accumulated first stress amount and the accumulated second stress amount that are calculated.

**Advantageous Effects**

The present disclosure can provide a display device and a display device driving method which are capable of reducing display unevenness even when under stress caused by environmental temperature.

**BRIEF DESCRIPTION OF DRAWINGS**

These and other advantages and features will become apparent from the following description thereof taken in conjunction with the accompanying Drawings, by way of non-limiting examples of embodiments disclosed herein.

FIG. 1 is an outline diagram illustrating a configuration of a display device according to an embodiment.

FIG. 2 is a circuit diagram illustrating a configuration of a pixel according to an embodiment.

FIG. 3 is a block diagram illustrating an example of a configuration of a correction circuit according to an embodiment.

FIG. 4 is a graph for describing a method of converting an input gradation value into a target luminance value according to an embodiment.

FIG. 5A is a graph for describing a method of calculating a corrected gradation value from a target luminance value according to an embodiment.

FIG. 5B is a graph for describing a method of calculating a corrected luminance value from a corrected gradation value according to an embodiment.

FIG. 6 is a graph illustrating a relationship between elapsed time and degree of deterioration of a light-emitting element.

FIG. 7A is a graph for describing a method of calculating a first current value that flows when a light-emitting element is first caused to emit light according to a corrected luminance value, according to an embodiment.

FIG. 7B is a graph for describing a method of converting a current stress amount when a first current flows through a light-emitting element into a current stress value when a reference current flows through the light-emitting element, according to an embodiment.

FIG. 8 is a graph for describing a method of converting a temperature stress amount on a light-emitting element under environmental temperature into a temperature stress amount on the light-emitting element under reference temperature, according to an embodiment.

FIG. 9A is a graph for describing a method of calculating a first efficiency residual ratio attributable to current stress, from the degree of luminance deterioration when a reference current flows through a light-emitting element for an accumulated time, according to an embodiment.

FIG. 9B is a graph for describing a method of calculating a second efficiency residual ratio attributable to temperature stress, from the degree of luminance deterioration when temperature stress under a reference temperature acts on a light-emitting element for an accumulated time, according to an embodiment.

FIG. 10 is a flowchart illustrating an example of a display device driving method according to an embodiment.

FIG. 11 is a graph illustrating prediction of life span characteristics using Arrhenius plot and actual life span characteristics of a light-emitting element.

#### DESCRIPTION OF EMBODIMENT

(Circumstances Leading to Obtainment of One Aspect of the Present Disclosure)

FIG. 11 is a graph illustrating prediction of life span characteristics using Arrhenius plot and actual life span characteristics of a light-emitting element.

In light-emitting elements such as organic EL elements, a light-emitting layer included in a luminescent element deteriorates due to temperature. It is generally known that, in such a light-emitting element, the life span characteristics attributable to temperature can be predicted using an Arrhenius plot. However, at 50° C., or more specifically, in the high temperature region of 70° C. to 100° C., life span characteristics attributable to temperature do not follow the prediction by Arrhenius plot and thus cannot be predicted using Arrhenius plot.

Meanwhile, in recent years, there are instances where light-emitting elements such as organic EL elements are used by being provided in vehicles as in a display of a car navigation system. In such a case, there are cases where the light-emitting elements operate in the high temperature region.

However, the aforementioned conventional technique does not take into consideration the case of operating a display in an environment which becomes relatively hot such as when the display is provided in a vehicle. For this reason, when operating light-emitting elements under stress caused by environmental temperature such in a hot environment, even when the video signal is corrected according to the aforementioned conventional technique, sufficient correction precision cannot be obtained, and, as a result,

correction error occurs, and there is the risk that display unevenness may occur in the display.

A display device according to an aspect of the present disclosure is a display device which includes a display screen in which pixels are arranged in a matrix, each of the pixels including a light-emitting element. The display device includes: a correction circuit which corrects an input gradation value indicated by a luminance signal included in a video signal. The correction circuit includes: a luminance converter which converts the input gradation value into a target luminance value corresponding to the input gradation value; a correction calculator which calculates an output gradation value from the target luminance value using an efficiency residual ratio which is an index representing a degree of deterioration of the light-emitting element, and calculates a corrected luminance value from the output gradation value, the output gradation value being obtained by correcting the input gradation value, the efficiency residual ratio indicating a residual ratio of light emission efficiency of the light-emitting element, the corrected luminance value being obtained by correcting the target luminance value; a current stress calculator which converts a current stress amount on the light-emitting element that is calculated from the corrected luminance value into a first stress amount indicating a current stress amount when a reference current flows through the light-emitting element, and calculates an accumulated first stress amount obtained by accumulating the first stress amount resulting from the conversion; a temperature stress calculator which converts a temperature stress amount on the light-emitting element under environmental temperature into a second stress amount indicating a temperature stress amount on the light-emitting element under a reference temperature, and calculates an accumulated second stress amount obtained by accumulating the second stress amount resulting from the conversion; and an efficiency residual ratio calculator which updates the efficiency residual ratio, using the accumulated first stress amount and the accumulated second stress amount that are calculated.

According to this configuration, display unevenness can be reduced even when there is stress due to environmental temperature.

More specifically, when there is stress due to environmental temperature, the accumulated stress amounts due to current and environmental temperature can be accurately calculated by independently calculating the stress amount due to current and the stress amount due to environmental temperature. For this reason, an efficiency residual ratio which takes into consideration the stress amount due to environmental temperature can be accurately calculated and updated, even when there is stress due to environmental temperature. In addition, since the degree of deterioration of the light-emitting element can be accurately predicted by using the updated efficiency residual ratio, an input gradation value that has been corrected taking into account the degree of deterioration of the light-emitting element, that is, the output gradation value can be accurately calculated. Accordingly, respective light-emitting elements can be corrected to a similar light emission luminance regardless of the degree of deterioration of each light-emitting element, and thus display unevenness can be reduced.

Furthermore, the efficiency residual ratio may be expressed by a ratio of a light emission luminance of the light-emitting element after deterioration to a light emission luminance of the light-emitting element at an initial stage of operation. The efficiency residual ratio calculator may calculate, using a relationship between a luminance of the

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light-emitting element and an accumulated time for which the reference current flows through the light-emitting element, a first efficiency residual ratio that is new and attributable to current stress, from the accumulated time which is calculated as the accumulated first stress amount; calculate, using a relationship between the luminance of the light-emitting element and an accumulated time for which the light-emitting element is exposed to the reference temperature, a second efficiency residual ratio that is new and attributable to temperature stress; and update the efficiency residual ratio by calculating the efficiency residual ratio from the first efficiency residual ratio and the second efficiency residual ratio.

According to this configuration, by independently calculating a new first efficiency residual ratio attributable to current stress and a new second efficiency residual ratio attributable to temperature stress, an efficiency residual ratio that takes into account the stress due to environmental temperature can be accurately calculated.

Furthermore, the current stress amount calculated from the corrected luminance value may be a stress amount for a first current that flows through the light-emitting element when the light-emitting element is caused to emit light according to the corrected luminance value. The stress amount for the first current may be equivalent to a time for which the first current flows through the light-emitting element. A stress amount for the reference current may be equivalent to a time for which the reference current flows through the light-emitting element. The current stress calculator may convert the current stress amount calculated from the corrected luminance value into the first stress amount by converting the time for which the first current flows through the light-emitting element into the time for which the reference current flows through the light-emitting element.

According to this configuration, by evaluating the current stress amount using the time for which the reference current flows through the light-emitting element, the stress amount due to current can be appropriately calculated, and the accumulated stress amount due to current can be accurately calculated.

Furthermore, the temperature stress amount on the light-emitting element under environmental temperature may be a stress amount on the light-emitting element exposed to the environmental temperature. The stress amount on the light-emitting element exposed to the environmental temperature may be equivalent to a time for which the light-emitting element is exposed to the environmental temperature. The temperature stress amount on the light-emitting element under a reference temperature may be equivalent to a time for which the light-emitting element is exposed to the reference temperature. The temperature stress calculator may convert the temperature stress amount on the light-emitting element under the environmental temperature into the second stress amount by converting the time for which the light-emitting element is exposed to the environmental temperature into the time for which the light-emitting element is exposed to the reference temperature.

According to this configuration, by evaluating the temperature stress amount using the time for which the light-emitting element is exposed to environmental temperature, stress amount due to environmental temperature can be appropriately calculated, and the accumulated stress amount due to environmental temperature can be accurately calculated.

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Furthermore, an environmental temperature of the pixel may be a temperature of the pixel when a voltage corresponding to the output gradation value is applied to the light-emitting element.

Furthermore, a display device driving method according to an aspect of the present disclosure is a method of driving a display device which includes a display screen in which pixels are arranged in a matrix, each of the pixels including a light-emitting element. The method includes: correcting an input gradation value indicated by a luminance signal included in a video signal. The correcting includes: converting the input gradation value into a target luminance value corresponding to the input gradation value; calculating an output gradation value from the target luminance value using an efficiency residual ratio which is an index representing a degree of deterioration of the light-emitting element, and calculating a corrected luminance value from the output gradation value, the output gradation value being obtained by correcting the input gradation value, the efficiency residual ratio indicating a residual ratio of light emission efficiency of the light-emitting element, the corrected luminance value being obtained by correcting the target luminance value; converting a current stress amount on the light-emitting element that is calculated from the corrected luminance value into a first stress amount indicating a current stress amount when a reference current flows through the light-emitting element, and calculating an accumulated first stress amount obtained by accumulating the first stress amount resulting from the conversion; converting a temperature stress amount on the light-emitting element under environmental temperature into a second stress amount indicating a temperature stress amount on the light-emitting element under a reference temperature, and calculating an accumulated second stress amount obtained by accumulating the second stress amount resulting from the conversion; and updating the efficiency residual ratio, using the accumulated first stress amount and the accumulated second stress amount that were calculated.

It should be noted that these generic and specific aspects may be implemented as a device, a system, a method, or an integrated circuit, or may be implemented as any combination of a device, a system, a method, and an integrated circuit.

Hereinafter, exemplary embodiments of the present invention will be described with reference to the drawings. Each of the exemplary embodiments described below shows one preferred example of the present disclosure. Therefore, numerical values, shapes, materials, structural components, the arrangement and connection of the structural components, etc., shown in the following exemplary embodiments are mere examples, and are not intended to limit the scope of the present disclosure. Furthermore, among the structural components in the following exemplary embodiment, components not recited in any one of the independent claims which indicate the broadest concepts of the present disclosure are described as arbitrary structural components.

It should be noted that the respective figures are schematic diagrams and are not necessarily precise illustrations. Furthermore, in the respective figures, the same reference sign is given to substantially identical components, and overlapping description is omitted or simplified.

[Configuration of Display Device]

Display device **1** according to the present disclosure is a display device including a display screen in which pixels, each including a light-emitting element, are arranged in a matrix.

Hereinafter, the configuration of display device **1** according to the present embodiment will be described.

FIG. **1** is an outline diagram illustrating the configuration of display device **1** according to the present embodiment.

As illustrated in FIG. **1**, in the present embodiment, display device **1** includes display screen **3**, gate driver circuit **4**, source driver circuit **5**, and correction circuit **10**.

(Display Screen **3**)

Display screen **3** displays video based on a video signal inputted to display device **1** from the outside. Here, the video signal includes at least a luminance signal, a vertical synchronization signal, and a horizontal synchronization signal. In the present embodiment, the luminance signal indicates, by a gradation value, the luminance of each subpixel of each of the pixels included in display screen **3**. Hereinafter, the gradation value indicated by the luminance signal will be referred to as the input gradation value.

Furthermore, as illustrated in FIG. **1**, in the present embodiment, display screen **3** includes pixels **2** arranged in a matrix, and rows of scanning lines **7** and columns of data lines **8** are provided.

(Pixel **2**)

FIG. **2** is a circuit diagram illustrating a configuration of pixel **2** according to the present embodiment.

Each of pixels **2** is electrically connected to scanning line **7** and data line **8**. More specifically, as illustrated in FIG. **1**, each of pixels **2** is disposed at a position at which one scanning line **7** and one data line **8** cross. Furthermore, pixels **2** are arranged in, for example, N rows and M columns. N and M are positive integers, and are different depending on the size and resolution of display screen **3**.

As illustrated in FIG. **2**, in the present embodiment, reference power supply line Vref, EL anode power supply line Vtft, EL cathode power supply line Vel, initialization power supply line Vini, reference voltage control line ref, initialization control line ini, and enable line enb are provided in pixel **2**. Here, EL anode power supply line Vtft supplies the anode voltage applied to light-emitting element **20**. EL cathode power supply line Vel supplies the cathode voltage applied to light-emitting element **20**. It should be noted that EL cathode power supply line Vel may be grounded. Initialization power supply line Vini supplies an initialization voltage when capacitive element **22** is initialized.

Furthermore, as illustrated in FIG. **2**, in the present embodiment, pixel **2** includes light-emitting element **20**, capacitive element **22**, drive transistor **24a**, and switch transistors **24b** to **24e**.

Light-emitting element **20** includes a cathode connected to EL cathode power supply line Vel, and an anode connected to the source of drive transistor **24a**. When current corresponding to a signal voltage of a video signal (luminance signal) supplied from drive transistor **24a** flows through light-emitting element **20**, light-emitting element **20** emits light at a luminance that is in accordance with the signal voltage. In the present embodiment, the current corresponding to the signal voltage of a video signal is a current corresponding to the signal voltage of the video signal that has been corrected by correction circuit **10**. Although details are to be described later, the current cor-

responding to the signal voltage of the video signal corrected by correction circuit **10** is a current corresponding to a gradation value (i.e., output gradation value) of the luminance indicated by the luminance signal included in the video signal. Here, the gradation value has been corrected by correction circuit **10**.

Light-emitting element **20** is an organic EL element such as an organic light-emitting diode (OLED), for example. It should be noted that light-emitting element **20** is not limited to an organic EL element, and may be a luminescent element such as an inorganic EL element a quantum-dot light-emitting diode (QLED), and need not be a luminescent element when it is an element controlled by being current driven.

Drive transistor **24a** includes a gate connected to one electrode of capacitive element **22**, etc., a drain connected to the source of switch transistor **24e**, and a source connected to the anode of light-emitting element **20**. In FIG. **2**, the source of drive transistor **24a** is further connected to the other electrode of capacitive element **22**, etc. Drive transistor **24a** converts the signal voltage applied across the gate and source into a current (referred to as drain-source current) corresponding to the signal voltage. Then, by being placed in the ON state, drive transistor **24a** applies (supplies) the drain-source current to light-emitting element **20** to cause light-emitting element **20** to emit light. Drive transistor **24a** is configured of, for example, an n-type thin film transistor (n-type TFT).

Switch transistor **24e** includes a gate connected to enable line enb, a drain connected to EL anode power supply line Vtft, and a source connected to the drain of drive transistor **24a**. Switch transistor **24e** is placed in the ON state or the OFF state according to a quenching signal supplied from enable line enb. By being placed in the ON state, switch transistor **24e** connects drive transistor **24a** to EL anode power supply line Vtft to cause the drain-source current of drive transistor **24a** to be supplied to light-emitting element **20**. Switch transistor **24e** is configured of, for example, an n-type thin film transistor (n-type TFT).

Switch transistor **24b** includes a gate connected to scanning line **7**, a drain connected to data line **8**, and a source connected to the one electrode of capacitive element **22**. Switch transistor **24b** is placed in the ON state or the OFF state according to a control signal supplied from scanning line **7**. By being placed in the ON state, switch transistor **24b** applies the signal voltage of the video signal supplied from data line **8** to the electrode of capacitive electrode **22** to cause a charge corresponding to the signal voltage to be accumulated in capacitive element **22**. Switch transistor **24b** is configured of, for example, an n-type thin film transistor (n-type TFT).

Switch transistor **24d** includes a gate connected to reference voltage control line ref, a drain connected to reference power supply line Vref, and a source connected to the one electrode of capacitive element **22**, etc. Switch transistor **24d** is placed in the ON state or the OFF state according to a control signal supplied from reference voltage control line ref. By being placed in the ON state, switch transistor **24d** sets the electrode of capacitive element **22** to the voltage supplied by reference power supply line Vref. Switch transistor **24d** is configured of, for example, an n-type thin film transistor (n-type TFT).

Switch transistor **24c** includes a gate connected to initialization control line ini, one of a source and a drain connected to the source of drive transistor **24a**, and the other of the source and the drain connected to initialization power supply line Vini. Switch transistor **24c** is placed in the ON state or

the OFF state according to a control signal supplied from initialization control line ini. By being placed in the ON state while drive transistor **24a** is in the ON state and switch transistor **24e** is in the OFF state, and the connection with EL anode power supply line Vtft is cut off, switch transistor **24c** sets the anode of light-emitting element **20** to the initialization voltage (reference voltage) supplied by initialization power supply line Vini. Switch transistor **24c** is configured of, for example, an n-type thin film transistor (n-type TFT).

Capacitive element **22** is a capacitor that includes the one electrode connected to the gate of drive transistor **24a**, the source of switch transistor **24b**, and the source of switch transistor **24d**, and the other electrode connected to the source of drive transistor **24a**. Capacitive element **22** accumulates a charge corresponding to the signal voltage supplied from data line **8**. Capacitive element **22**, for example, stably holds the gate-source voltage of drive transistor **24a** after switch transistor **24b** and switch transistor **24d** are placed in the OFF state. In this manner, when switch transistor **24b** and switch transistor **24d** are in the OFF state, capacitive element **22** applies the gate-source voltage of drive transistor **24a** according to the signal potential of the accumulated charge.

With this configuration pixel **2** can stably pass current to light-emitting element **20**.

It should be noted that the configuration of pixel **2** is not limited to the configuration in illustrated in FIG. **2**, and may be another configuration. As a minimum configuration that is capable of at least achieving the functions of pixel **2**, it is sufficient that light-emitting element **20**, capacitive element **22**, drive transistor **24a**, and switch transistor **24b** be included.

Scanning line **7** is provided for each row of pixels **2**. One end of scanning line **7** is connected to pixel **2**, and the other end of scanning line **7** is connected to gate driver circuit **4**. In the example illustrated in FIG. **2**, scanning line **7** is connected to the gate of switch transistor **24b** disposed in pixel **2**.

Data line **8** is provided for each column of pixels **2**. One end of data line **8** is connected to pixel **2**, and the other end of data line **8** is connected to source driver circuit **5**. In the example illustrated in FIG. **2**, data line **8** is connected to the drain of switch transistor **24b**.

(Gate Driver Circuit **4**)

Scanning lines **7** are connected to gate driver circuit **4**, and gate driver circuit **4** controls the turning ON and OFF of respective transistors included in each pixel **2** by outputting a control signal to scanning lines **7**. In the example illustrated in FIG. **2**, gate driver circuit **4** supplies a scanning signal to the gate of switch transistor **24b** disposed in pixel **2**, via scanning line **7**.

(Source Driver Circuit **5**)

Data lines **8** are connected to source driver circuit **5**, and source driver circuit **5** supplies the video signal corrected by correction circuit **10** to respective pixels **2** by outputting the video signal to data lines **8**. Source driver circuit **5** writes the output gradation value representing the luminance indicated by the video signal in each of pixels **2**, in the form of a current value or a voltage value, via data lines **8**. In the example illustrated in FIG. **2**, source driver circuit **5** supplies, via data line **8**, a voltage corresponding to the video signal input to the drain of switch transistor **24b** disposed in pixel **2**.

(Correction Circuit **10**)

Correction circuit **10** corrects a video signal inputted from the outside, and outputs the corrected video signal to source driver circuit **5**. More specifically, correction circuit **10**

corrects the input gradation value indicated by the luminance signal included in the video signal to output an output gradation value. Accordingly, the output gradation value is outputted to source driver circuit **5** as the gradation indicated by the luminance signal included in the video signal.

Stated differently, correction circuit **10** is a circuit for correcting the gradation value (i.e., input gradation value) of the luminance indicated by the luminance signal included in the video signal so that light-emitting element **20** emits light at the targeted luminance, that is, the target luminance value. It should be noted that the target luminance value corresponds to the light-emission luminance value corresponding to the input gradation value, in a light-emitting element **20** that is in an initial stage of operation with no deterioration. For this reason, when light-emitting element **20** deteriorates, the target luminance value cannot be achieved even if light-emitting element **20** is caused to emit light by supplying the current value corresponding to the input gradation value indicated by the luminance signal included in the video signal. In view of this, correction circuit **10** corrects the input gradation value indicated by the luminance signal included in the video signal to be able to achieve the target luminance value. Accordingly, light-emitting element **20** which has been supplied with current corresponding to the corrected input gradation value (i.e., output gradation value) can achieve the targeted luminance, that is, the target luminance value.

The configuration of correction circuit **10** will be described below.

[Configuration of Correction Circuit **10**]

FIG. **3** is a block diagram illustrating an example of a configuration of correction circuit **10** according to the present embodiment.

Correction circuit **10** includes luminance converter **11**, luminance correction calculator **12**, and accumulated stress calculator **13**. Correction circuit **10** can be implemented by a processor executing a predetermined program using a memory. The respective structural components will be described below.

(Luminance Converter **11**)

Luminance converter **11** converts the input gradation value into the corresponding target luminance value. In the present embodiment, luminance converter **11** converts the input gradation value indicated by the luminance signal included in the video signal inputted from the outside of display device **1** into the corresponding target luminance value.

This will be described using FIG. **4**.

FIG. **4** is a graph for describing a method of converting the input gradation value into a target luminance value according to an embodiment. FIG. **4** illustrates gradation-luminance characteristics representing the relationship between the gradation value and the luminance value of light-emitting element **20** that is in an initial stage of operation.

Using the relationship shown by the gradation-luminance characteristics in FIG. **4**, luminance converter **11** can convert the input gradation value indicated by the luminance signal included in the video signal inputted from the outside of display device **1** into the corresponding target luminance value.

(Luminance Correction Calculator **12**)

Using the efficiency residual ratio which is an index representing the degree of deterioration of light-emitting element **20** and indicates the residual ratio of the light-emitting efficiency of light-emitting element **20**, luminance correction calculator **12** calculates, from the target lumi-

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nance value, the output gradation value obtained by correcting the input gradation value, and calculates, from the calculated output gradation value, the corrected luminance value obtained by correcting the target luminance value. Here, efficiency residual ratio is expressed by the ratio of the post-deterioration light-emitting luminance of light-emitting element 20 to the initial light-emitting luminance of light-emitting element 20.

In the present embodiment, luminance correction calculator 12 calculates the output gradation value from the target luminance value outputted by luminance converter 11, using the efficiency residual ratio which is obtained from accumulated stress calculator 13 and takes into consideration the stress due to environmental temperature. Here, the output gradation value is the corrected gradation value obtained by correcting the input gradation value indicated by the luminance signal included in the video signal inputted from the outside of display device 1. Luminance correction calculator 12 outputs the calculated output gradation value. Accordingly, luminance correction calculator 12 can output the calculated output gradation value to source driver circuit 5, as the gradation indicated by the luminance signal included in the video signal.

Furthermore, luminance correction calculator 12 calculates, from the calculated output gradation value, a corrected luminance value obtained by correcting the target luminance value. Luminance correction calculator 12 outputs the calculated corrected luminance value to accumulated stress calculator 13.

The method for calculating the output gradation value and the corrected luminance value will be described below using FIG. 5A and FIG. 5B.

FIG. 5A is a graph for describing a method of calculating a corrected gradation value from a target luminance value according to the present embodiment. FIG. 5B is a graph for describing a method of calculating a corrected luminance value from a corrected gradation value according to the present embodiment. FIG. 5A and FIG. 5B illustrate gradation-luminance characteristics representing the relationship between the gradation value and the luminance value of light-emitting element 20 in the initial stage of operation and after deterioration. The gradation-luminance characteristics after deterioration can be obtained by multiplying the gradation-luminance characteristics at the initial stage of operation by efficiency residual ratio  $\eta_{\text{acc}}$ .

Using the relationship shown by the gradation-luminance characteristics after deterioration in FIG. 5A, luminance correction calculator 12 can calculate the gradation value corresponding to the target luminance value outputted by luminance converter 11, as the corrected gradation value obtained by correcting the input gradation value indicated by the luminance signal included in the video signal. Then, luminance correction calculator 12 outputs the calculated corrected gradation value as an output gradation value. Accordingly, the input gradation value indicated by the luminance signal included in the video signal inputted from the outside of display device 1 is corrected to become the output gradation value, and the output gradation value is inputted to source driver circuit 5.

Furthermore, using the relationship shown by the gradation-luminance characteristics at the initial stage of operation in FIG. 5B, luminance correction calculator 12 can calculate the luminance value corresponding to the calculated corrected gradation value, as the corrected luminance value obtained by correcting the target luminance value outputted by luminance converter 11. Then, luminance cor-

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rection calculator 12 outputs the calculated corrected luminance value to accumulated stress calculator 13. (Accumulated Stress Calculator 13)

In the present embodiment, the deterioration of light-emitting element 20 due to current and the deterioration of light-emitting element 20 due to environmental temperature are calculated separately as independent phenomena. Specifically, accumulated stress calculator 13 calculates deterioration due to various currents as an accumulated stress amount due to current, and calculates deterioration due to various environmental temperatures as an accumulated stress amount due to environmental temperature.

More specifically, accumulated stress calculator 13 independently calculates the accumulated stress amounts due to current and environmental temperature by independently calculating the stress amount due to current and the stress amount due to environmental temperature. In addition, accumulated stress calculator 13 calculates an efficiency residual ratio that takes into consideration the stress due to environmental temperature, by independently calculating a first efficiency residual ratio attributable to current stress and a second efficiency residual value attributable to temperature stress. Accordingly, even when under stress due to environmental temperature, accumulated stress calculator 13 can accurately calculate an efficiency residual ratio that takes into consideration stress due to environmental temperature.

In addition, accumulated stress calculator 13 updates the efficiency residual ratio used by luminance correction calculator 12 with the newly calculated efficiency residual ratio. [Detailed Configuration of Accumulated Stress Calculator 13]

Next, the detailed configuration of accumulated stress calculator 13 according to the present embodiment will be described.

As illustrated in FIG. 3, in the present embodiment, accumulated stress calculator 13 includes current stress calculator 131, temperature stress calculator 132, and efficiency residual ratio calculator 133. These components will be described in detail below.

(Current Stress Calculator 131)

Current stress calculator 131 converts the current stress amount on light-emitting element 20 that is calculated from the corrected luminance value into the first stress amount indicating the current stress amount when the reference current flows through light-emitting element 20.

Here, the current stress amount that is calculated from the corrected luminance value is the amount of stress from a first current that flows through light-emitting element 20 when light-emitting element 20 is caused to emit light according to the corrected luminance value, and is equivalent to the time for which the first current flows through light-emitting element 20. In the same manner, the current stress amount for the reference current is equivalent to the time for which the reference current flows through light-emitting element 20.

For this reason, more specifically, current stress calculator 131 can convert the stress amount calculated from the corrected luminance value into the first stress amount by converting the time for which the first current flows through light-emitting element 20 into the time for which the reference current flows through light-emitting element 20. Then, current stress calculator 131 calculates an accumulated first stress amount obtained by accumulating the first stress amount resulting from the conversion.

In this manner, current stress calculator 131 calculates the deterioration due to various currents as an accumulated stress amount due to current, and thus the current stress on

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light-emitting element 20 caused by various currents is converted to current stress due to the reference current and accumulated.

FIG. 6 is a graph illustrating a relationship between elapsed time and degree of deterioration of a light-emitting element.

As described above, it is known that, in a light-emitting element (luminescent element) such as an organic EL element, the light-emitting layer included in the light-emitting element deteriorates according to the light-emission amount, the light-emission time (duration), and the temperature. FIG. 6 illustrates the degree of deterioration over elapsed time when a constant current is continuously applied to the light-emitting element, with the current applied to the light-emitting element as stress (called current stress). For current stress A and current stress B, the magnitude of the current applied to the light-emitting element is different, and current stress A is greater than current stress B, that is, the current applied as current stress A is greater than the current applied as current stress B.

As illustrated in FIG. 6, it can be seen that, when the light-emitting element is under current stress, deterioration advances with the passing of time. Furthermore, deterioration advances more when the light-emitting element is under current stress A than when the light-emitting element is under current stress B. Specifically, as indicated by the dotted line circle in FIG. 6, it can be seen that, even when the elapsed time is the same, the degree of deterioration is different according to the current stress, and the greater the current stress is, the more deterioration advances.

It should be noted that, since the magnitude of the current supplied to light-emitting element 20 is different (i.e., not constant) according to the input gradation value indicated by the luminance signal included in the video signal, it is difficult to simply express the relationship between elapsed time and the degree of deterioration of light-emitting element 20.

In view of this, in the present embodiment, the degree of deterioration caused by the current stress amount on light-emitting element 20 is evaluated using the degree of deterioration according to accumulated time (elapsed time) for the time when a constant current (i.e., reference current) is supplied to light-emitting element 20. In this manner, the current stress amount can be calculated by the current stress amount on light-emitting element 20 being evaluated using the time of various currents (first current) applied (supplied) to light-emitting element 20, and, in addition, being converted to the time for which the reference current flows through light-emitting element 20. Then, the current stress amount accumulated on light-emitting element 20 can be calculated by calculating the accumulated time obtained by accumulating the time resulting from the conversion.

FIG. 7A is a graph for describing a method of calculating the first current value that flows when light-emitting element 20 is caused to emit light according to the corrected luminance value, according to an embodiment. FIG. 7A illustrates a curve (initial characteristics) showing the relationship between luminance value and the current value flowing through light-emitting element 20 that is in an initial stage of operation.

Using the curve in FIG. 7A, current stress calculator 131 calculates, from the corrected luminance value outputted from luminance correction calculator 12, a first current that flows when light-emitting element 20 is caused to emit light according to the corrected luminance value.

FIG. 7B is a graph for describing a method of converting the current stress amount when the first current flows

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through light-emitting element 20 into the current stress value when the reference current flows through light-emitting element 20, according to an embodiment. The curves illustrated in FIG. 7B show the relationship between elapsed time and the degree of deterioration of the luminance of light-emitting element 20 when a reference current and a first current flow through light-emitting element 20 as current stress. It should be noted that, in FIG. 7B, the degree of deterioration of the luminance of light-emitting element 20 at the initial stage of operation in which there is absolutely no current stress, is normalized to 1. Furthermore, each of the two curves illustrated in FIG. 7B is prepared in advance.

Current stress calculator 131 converts the time for which the first current flows into the time for which the reference current flows through light-emitting element 20 so as to obtain a stress amount equivalent to the current stress amount when the first current is applied to light-emitting element 20. More specifically, using the curves shown in FIG. 7B, current stress calculator 131 converts time T1 for which the first current flows to time T2 for which the reference current flows so as to obtain a luminance deterioration degree equivalent to the luminance deterioration degree when the first current is applied to light-emitting element 20 for time T1. Specifically, as illustrated in FIG. 7B, time T1 for which the first current flows through light-emitting element 20, that is, time T1 of current stress I1 can be converted to time T2 for which the reference current flows through light-emitting element 20, that is, time T2 of current stress Iref. In this manner, current stress calculator 131 can convert the current stress amount that is calculated from the corrected luminance value into the first stress amount.

Then, current stress calculator 131 calculates accumulated time  $\Sigma T2$  of time T2 as a first accumulated stress amount, by adding time T2 obtained as the first stress amount to time  $\Sigma T2$  which is previously obtained and accumulated. (Temperature Stress Calculator 132)

Temperature stress calculator 132 converts the temperature stress amount on light-emitting element 20 which is under environmental temperature into a second stress amount indicating the temperature amount on light-emitting element 20 under a reference temperature, and calculates an accumulated second stress amount obtained by accumulating the second stress amount resulting from the conversion. It should be noted that environmental temperature is, for example, the temperature of the pixel when the output gradation value is applied to light-emitting element 20.

Here, the temperature stress amount on light-emitting element 20 which is under environmental temperature is the stress amount on light-emitting element 20 which is exposed to environmental temperature, and can be evaluated using the time for which light-emitting element 20 is exposed to environmental temperature. In the same manner, the temperature stress amount on light-emitting element 20 that is under reference temperature can be evaluated using the time for which light-emitting element 20 is exposed to environmental temperature.

For this reason, more specifically, temperature stress calculator 132 can convert the temperature stress amount on light-emitting element 20 under environmental temperature to a second stress amount by converting the time for which light-emitting element 20 is exposed to environmental temperature to the time for which light-emitting element 20 is exposed to the reference temperature. Then, temperature stress calculator 132 calculates an accumulated second stress amount obtained by accumulating the second stress amount resulting from the conversion.

In this manner, temperature stress calculator 132 calculates the deterioration due to various environmental temperatures as an accumulated stress amount due to environmental temperature, and thus the temperature stress on light-emitting element 20 caused by various environmental temperatures is converted to temperature stress due to the reference temperature and accumulated.

As described above, in a light-emitting element (luminescent element) such as an organic EL element, the light-emitting layer included in the light-emitting element deteriorates according to the temperature (environmental temperature). In addition, the stress (hereafter called temperature stress) on the light-emitting element under environmental temperature increases with a higher environmental temperature. Specifically, like the current stress illustrated in FIG. 6, even when the elapsed time is the same, the degree of deterioration is different according to the magnitude of temperature stress, and greater temperature stress causes deterioration to advance more.

In view of this, in the present embodiment, the degree of deterioration due to temperature stress on light-emitting element 20 which is exposed to environmental temperature is evaluated using the degree of deterioration according to accumulated time (elapsed time) of the time for which light-emitting element 20 is exposed to the reference temperature. In this manner, the temperature stress amount can be calculated by the stress amount on light-emitting element 20 under environmental temperature being evaluated using the time for which light-emitting element 20 is exposed to environmental temperature, and, in addition, being converted to the time for which light-emitting element 20 is exposed to the reference temperature. Then, the temperature stress amount accumulated on light-emitting element 20 can be calculated by calculating the accumulated time obtained by accumulating the time resulting from the conversion.

FIG. 8 is a graph for describing a method of converting a temperature stress amount on light-emitting element 20 under environmental temperature into a temperature stress amount on light-emitting element 20 under a reference temperature, according to an embodiment. The curves illustrated in FIG. 8 show the relationship between elapsed time and the degree of deterioration of luminance of light-emitting element 20 when, as the temperature stress on light-emitting element 20, the environmental temperature is a first temperature (temperature stress: K1) and when the environmental temperature is a reference temperature (temperature stress: Kref). It should be noted that, in FIG. 8, the degree of deterioration of the luminance of light-emitting element 20 at the initial stage of operation in which there is absolutely no temperature stress, is normalized to 1. Furthermore, each of the two curves illustrated in FIG. 8 is prepared in advance.

Temperature stress calculator 132 converts the time for which light-emitting element 20 is exposed to the first temperature which is the environmental temperature to the time for which light-emitting element 20 is exposed to the reference temperature so as to obtain a stress amount equivalent to the temperature stress amount on light-emitting element 20 under the first temperature. More specifically, using the curves illustrated in FIG. 8, temperature stress calculator 132 converts time S1 for which light-emitting element 20 is exposed to the first temperature which is the environmental temperature, which is evaluated as the temperature stress amount on light-emitting element 20 under the first temperature, into time S2 for which light-emitting element 20 is exposed to the reference temperature. Specifically, as illustrated in FIG. 8, S1 for which light-emitting

element 20 is exposed to the first temperature, that is, time S1 for temperature stress K1 can be converted to time S2 for which light-emitting element 20 is exposed to the reference temperature, that is, time S2 for temperature stress Kref. In this manner, temperature stress calculator 132 can convert the temperature stress amount on light-emitting element 20 under environmental temperature to a second stress amount.

Then, temperature stress calculator 132 calculates accumulated time  $\Sigma S2$  of time S2 as a second accumulated stress amount, by further adding time S2 obtained as the second stress amount to time  $\Sigma S2$  which is previously obtained and accumulated.

(Efficiency Residual Ratio Calculator 133)

Efficiency residual ratio calculator 133 updates an efficiency residual ratio using the calculated accumulated first stress amount and accumulated second stress amount. More specifically, using the relationship between the luminance of light-emitting element 20 and the accumulated time for which the reference current flows through light-emitting element 20, efficiency residual ratio calculator 133 calculates a new first efficiency residual ratio attributable to current stress, from the accumulated time calculated as the accumulated first stress amount. Furthermore, using the relationship between the luminance of light-emitting element 20 and the accumulated time for which light-emitting element 20 is exposed to the reference temperature, efficiency residual ratio calculator 133 calculates a new second efficiency residual ratio attributable to temperature stress, from the accumulated time calculated as the accumulated second stress amount. In addition, efficiency residual ratio calculator 133 updates the efficiency residual ratio by calculating a new efficiency residual ratio from the calculated first efficiency residual ratio and second efficiency residual ratio.

In the present embodiment, using the curve illustrated in FIG. 9A, efficiency residual ratio calculator 133 calculates first efficiency residual ratio  $\eta_{-Iref}$  attributable to current stress from accumulated time  $\Sigma T2$  calculated by current stress calculator 131.

FIG. 9A is a graph for describing a method of calculating first efficiency residual ratio  $\eta_{-Iref}$  attributable to current stress, from the degree of deterioration of luminance when a reference current flows through light-emitting element 20 for an accumulated time, according to an embodiment. The curve illustrated in FIG. 9A shows the relationship between elapsed time (accumulated time) and the degree of deterioration of the luminance of light-emitting element 20 when a reference current flows through light-emitting element 20 as current stress.

In the curve illustrated in FIG. 9A, the light emission luminance when accumulated time  $\Sigma T2$  is 0 is not deteriorated, and thus corresponds to the light emission luminance of light-emitting element 20 at the initial stage of operation. For this reason, the light emission luminance of light-emitting element 20 for accumulated time  $\Sigma T2$  can be expressed as the ratio of the light emission luminance of light-emitting element 20 after deterioration to the light emission luminance of light-emitting element 20 at the initial stage of operation. Specifically, using the curve illustrated in FIG. 9A, efficiency residual ratio calculator 133 can calculate first efficiency residual ratio  $\eta_{-Iref}$  from accumulated time  $\Sigma T2$ .

It should be noted that, in FIG. 9A, the undeteriorated light emission luminance of light-emitting element 20 at the initial stage of operation is normalized to 1.

Furthermore, in the present embodiment, using the curve illustrated in FIG. 9B, efficiency residual ratio calculator 133

calculates second efficiency residual ratio  $\eta_{-Kref}$  attributable to temperature stress, from accumulated time  $\Sigma S2$  calculated by temperature stress calculator 132.

FIG. 9B is a graph for describing a method of calculating second efficiency residual ratio  $\eta_{-Kref}$  attributable to temperature stress, from the degree of deterioration of luminance when temperature stress under a reference temperature acts on light-emitting element 20 for an accumulated time, according to the present embodiment. The curve illustrated in FIG. 9B shows the relationship between elapsed time (accumulated time) and the degree of deterioration of the luminance of light-emitting element 20 when temperature stress under a reference temperature acts on light-emitting element 20.

In the curve illustrated in FIG. 9B, the light emission luminance when accumulated time  $\Sigma S2$  is 0 is not deteriorated, and thus corresponds to the light emission luminance of light-emitting element 20 at the initial stage of operation. For this reason, the light emission luminance of light-emitting element 20 for accumulated time  $\Sigma S2$  can be expressed as the ratio of the light emission luminance of light-emitting element 20 after deterioration to the light emission luminance of light-emitting element 20 at the initial stage of operation. Specifically, using the curve illustrated in FIG. 9B, efficiency residual ratio calculator 133 can calculate second efficiency residual ratio  $\eta_{-Kref}$  from accumulated time  $\Sigma S2$ . It should be noted that, in FIG. 9B, the undeteriorated light emission luminance of light-emitting element 20 at the initial stage of operation is normalized to 1.

In addition, in the present embodiment, efficiency residual ratio calculator 133 calculates efficiency residual ratio  $\eta_{-x}$  which takes into consideration current stress and temperature stress, using separately (independently) calculated first efficiency residual ratio  $\eta_{-Iref}$  attributable to current stress and second efficiency residual ratio  $\eta_{-Kref}$  attributable to temperature stress.

More specifically, using (Equation 1) below, efficiency residual ratio calculator 133 calculates efficiency residual ratio  $\eta_{-x}$  from separately (independently) calculated first efficiency residual ratio  $\eta_{-Iref}$  and second efficiency residual ratio  $\eta_{-Kref}$ . In addition, efficiency residual ratio calculator 133 updates the immediately preceding efficiency residual ratio  $\eta_{-x}$  with the calculated efficiency residual ratio  $\eta_{-x}$ .

[Math. 1]

$$\eta_{-x} = 1 - (1 - \eta_{-Iref}) - (1 - \eta_{-Kref}) \quad \text{(Equation 1)}$$

As shown in (Equation 1), efficiency residual ratio  $\eta_{-x}$  which takes into consideration current stress and temperature stress can be expressed in a form in which second efficiency residual ratio  $\eta_{-Kref}$  attributable to temperature stress is added, in addition to first efficiency residual ratio  $\eta_{-Iref}$  attributable to current stress. In other words, although the deterioration of light-emitting element 20 due to current and the deterioration of light-emitting element 20 due to environmental temperature are independent phenomena, the deterioration of light-emitting element 20 can be expressed by adding together these phenomena. Then, in a high temperature region of from 80° C. to 90° C., second efficiency residual ratio  $\eta_{-Kref}$  attributable to temperature stress takes effect. Specifically, efficiency residual ratio  $\eta_{-x}$  can be accurately calculated even under environmental temperature when prediction by Arrhenius plot is not possible.

[Method of Driving Display Device 1]

Next, a method of driving display device 1 configured as described above will be described.

FIG. 10 is a flowchart illustrating an example of a method of driving display device 1 according to the present embodiment. FIG. 10 illustrates a process performed by correction circuit 10 included in display device 1 as an example of a method of driving display device 1.

First, correction circuit 10 converts the input gradation value indicated by a luminance signal included in a video signal inputted from the outside of display device 1, into the corresponding target luminance value (S10).

Next, correction circuit 10 calculates an output gradation value obtained by correcting an input gradation value, from the target luminance value resulting from the conversion in step S10, using the efficiency residual ratio, and calculates a corrected luminance value obtained by correcting the target luminance value, from the output gradation value (S11). The efficiency residual ratio is calculated by accumulated stress calculator 13 in an immediately preceding process and so on.

Next, correction circuit 10 converts a current stress amount calculated from the corrected luminance value calculated in step S11 into a current stress amount for a reference voltage, and calculates an accumulated first stress amount obtained by accumulating the current stress amount resulting from the conversion (S12). More specifically, correction circuit 10 converts the current stress amount on light-emitting element 20 calculated from the corrected luminance value calculated in step S11 into a first stress amount indicating the current stress amount when the reference current flows through light-emitting element 20. Then, correction circuit 10 calculates the accumulated first stress amount obtained by accumulating the first stress amount resulting from the conversion (S12).

Next, correction circuit 10 converts a temperature stress amount calculated from the environmental temperature into the temperature stress amount for a reference temperature, and calculates an accumulated second stress amount obtained by accumulating the temperature stress amount resulting from the conversion (S13). Here, the order of step S12 and step S13 may be changed. More specifically, correction circuit 10 obtains the environmental temperature, and converts the temperature stress amount on light-emitting element 20 under environmental temperature, which is calculated from the obtained environmental temperature, into a second stress amount indicating the temperature stress amount on light-emitting element 20 under the reference temperature. Then, correction circuit 10 calculates the accumulated second stress amount obtained by accumulating the second stress amount resulting from the conversion.

Next, correction circuit 10 calculates an efficiency residual ratio which takes into consideration current stress and temperature stress, from the accumulated first stress amount and the accumulated second stress amount that were calculated in step S12 and step S13, respectively (S14). [Advantageous Effects, Etc.]

As described above, display device 1 according to the present embodiment can reduce display unevenness even when under stress due to environmental temperature.

More specifically, as described above, deterioration of the light-emitting element due to current and deterioration of the light-emitting element due to environmental temperature are calculated separately as independent phenomena. Then, deterioration due to various currents is calculated as an accumulated stress amount due to current, and deterioration due to various environmental temperatures is calculated as an accumulated stress amount due to environmental temperature.

Stated differently, display device 1 according to the present embodiment can accurately calculate the accumulated

stress amounts due to current and environmental temperature by independently calculating the stress amount due to current and the stress amount due to environmental temperature. For this reason, an efficiency residual ratio which takes into consideration the stress amount due to environmental temperature can be accurately calculated and updated, even when under stress due to environmental temperature. Then, by using the updated efficiency residual ratio, it is possible to accurately predict the degree of deterioration of light-emitting element **20** even under environmental temperature in which prediction by Arrhenius plot is not possible, and an input gradation value that is corrected with consideration to the degree of deterioration of light-emitting element **20**, that is, the output gradation value, can be calculated. Accordingly, even when there is stress due to environmental temperature, respective light-emitting elements **20** can be corrected to a similar light emission luminance regardless of the degree of deterioration of each light-emitting element **20**, and thus display unevenness can be reduced.

Furthermore, display device **1** according to the present embodiment can accurately calculate and update an efficiency residual ratio that takes into consideration stress due to environmental temperature, by independently calculating a first efficiency residual ratio attributable to current stress and a second efficiency residual ratio attributable to temperature stress.

Here, with deterioration behavior due to current and deterioration behavior due to environmental temperature being taken as independent phenomena, display device **1** according to the present embodiment separately calculates the accumulated stress amount due to current and the accumulated stress amount due to temperature.

Specifically, deterioration due to various currents is converted into a stress amount due to a reference current and accumulated. More specifically, display device **1** according to the present embodiment evaluates the current stress amount using the time for which the reference current flows through the light-emitting element to thereby appropriately calculate the stress amount due to current, and accurately calculate the accumulated stress amount due to current.

Furthermore, deterioration due to various temperatures is converted to the stress amount due to a reference temperature and accumulated. More specifically, display device **1** according to the present embodiment evaluates the temperature stress amount using the time for which the light-emitting element is exposed to environmental temperature to thereby appropriately calculate the stress amount due to environmental temperature, and accurately calculate the accumulated stress amount due to environmental temperature.

Although display device **1** according to an exemplary embodiment and working examples has been described above, display device **1** is not limited to the above-described exemplary embodiment.

For example, a gain calculator may be provided to the above-described correction circuit **10**, and when the efficiency residual ratio obtained from the accumulation stress calculator is small, the efficiency residual value may be amplified according to a gain calculated by the gain calculator.

Furthermore, forms obtained by various modifications to the exemplary embodiment as well forms realized by combining structural components of different exemplary embodiments that may be conceived by those skilled in the

art, so long as these do not depart from the essence of the present disclosure are included within the scope of the present disclosure.

Although only some exemplary embodiments of the present disclosure have been described in detail above, those skilled in the art will readily appreciate that many modifications are possible in the exemplary embodiments without materially departing from the novel teachings and advantages of the present disclosure. Accordingly, all such modifications are intended to be included within the scope of the present disclosure.

#### INDUSTRIAL APPLICABILITY

The present disclosure can be used in a display device and a method of driving a display device, and can be used in particular in a display device and a method of driving a display device in the technical field of displays of thin-screen televisions or personal computers having luminescent elements and for which large screens and high resolution are demanded.

The invention claimed is:

**1.** A display device which includes a display screen in which pixels are arranged in a matrix, each of the pixels including a light-emitting element, the display device comprising:

a processor which corrects an input gradation value indicated by a luminance signal included in a video signal; and

a memory including a program, wherein

the program, when executed by the processor, causes the processor to perform operations, the operations including:

converting the input gradation value into a target luminance value corresponding to the input gradation value;

calculating an output gradation value from the target luminance value using an efficiency residual ratio, the efficiency residual ratio being an index representing a degree of deterioration of the light-emitting element according to a light-emission amount, a light-emission time, and a light-emission temperature over time, and calculating a corrected luminance value from the output gradation value, the output gradation value being obtained by correcting the input gradation value, the efficiency residual ratio indicating a residual ratio of light emission efficiency of the light-emitting element, the corrected luminance value being obtained by correcting the target luminance value;

determining a magnitude of current supplied to the light-emitting element according to the corrected luminance value to obtain a current stress amount on the light-emitting element;

converting a first time for which the magnitude of current flows into the light-emitting element into a second time for which a reference current flows to obtain a first reference stress amount equivalent to the current stress amount on the light-emitting element and calculating an accumulated first reference stress amount obtained by accumulating the first reference stress amount resulting from the conversion;

determining an environmental temperature of the light-emitting element to obtain a temperature stress amount on the light-emitting element;

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converting the first time at which the light-emitting element is exposed to the environmental temperature into a third time at which the light-emitting element is exposed to a reference temperature to obtain a second reference stress amount equivalent to the temperature stress amount on the light-emitting element under the environmental temperature, and calculating an accumulated second reference stress amount obtained by accumulating the second reference stress amount resulting from the conversion; and

updating the efficiency residual ratio, using the accumulated first reference stress amount and the accumulated second reference stress amount that are calculated.

2. The display device according to claim 1, wherein the efficiency residual ratio is expressed by a ratio of a light emission luminance of the light-emitting element after deterioration to a light emission luminance of the light-emitting element at an initial stage of operation, and

the processor:

- calculates, using a relationship between a luminance of the light-emitting element and an accumulated time for which the reference current flows through the light-emitting element, a first efficiency residual ratio that is new and attributable to current stress, from the accumulated time which is calculated as the accumulated first reference stress amount;
- calculates, using a relationship between the luminance of the light-emitting element and an accumulated time for which the light-emitting element is exposed to the environmental temperature, a second efficiency residual ratio that is new and attributable to temperature stress; and
- updates the efficiency residual ratio by calculating an updated efficiency residual ratio from the first efficiency residual ratio and the second efficiency residual ratio.

3. The display device according to claim 1, wherein the current stress amount calculated from the corrected luminance value is a stress amount for a first current that flows through the light-emitting element when the light-emitting element is caused to emit light according to the corrected luminance value,

the stress amount for the first current is equivalent to the first time for which the first current flows through the light-emitting element,

a stress amount for the reference current is equivalent to the second time for which the reference current flows through the light-emitting element, and

the current stress calculator converts the current stress amount calculated from the corrected luminance value into the first reference stress amount by converting the first time for which the first current flows through the light-emitting element into the second time for which the reference current flows through the light-emitting element.

4. The display device according to claim 1, wherein the temperature stress amount on the light-emitting element under the environmental temperature is a stress amount on the light-emitting element exposed to the environmental temperature,

the stress amount on the light-emitting element exposed to the environmental temperature is equivalent to the first time for which the light-emitting element is exposed to the environmental temperature,

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the temperature stress amount on the light-emitting element under the reference temperature is equivalent to the third time for which the light-emitting element is exposed to the reference temperature, and

the temperature stress calculator converts the temperature stress amount on the light-emitting element under the environmental temperature into the second reference stress amount by converting the first time for which the light-emitting element is exposed to the environmental temperature into the third time for which the light-emitting element is exposed to the reference temperature.

5. The display device according to claim 1, wherein the environmental temperature of the pixel is a temperature of the pixel when a voltage corresponding to the output gradation value is applied to the light-emitting element.

6. A method of driving a display device which includes a display screen in which pixels are arranged in a matrix, each of the pixels including a light-emitting element, the method comprising:

- correcting an input gradation value indicated by a luminance signal included in a video signal, wherein the correcting includes:
  - converting the input gradation value into a target luminance value corresponding to the input gradation value;
  - calculating an output gradation value from the target luminance value using an efficiency residual ratio, the efficiency residual ratio being an index representing a degree of deterioration of the light-emitting element according to a light-emission amount, a light-emission time, and a light-emission temperature over time, and calculating a corrected luminance value from the output gradation value, the output gradation value being obtained by correcting the input gradation value, the efficiency residual ratio indicating a residual ratio of light emission efficiency of the light-emitting element, the corrected luminance value being obtained by correcting the target luminance value;
  - determining a magnitude of current supplied to the light-emitting element according to the corrected luminance value to obtain a current stress amount on the light-emitting element;
  - converting a first time for which the magnitude of current flows into the light-emitting element into a second time for which a reference current flows to obtain a first reference stress amount equivalent to the current stress amount on the light-emitting element, and calculating an accumulated first reference stress amount obtained by accumulating the first reference stress amount resulting from the conversion;
  - determining an environmental temperature of the light-emitting element to obtain a temperature stress amount on the light-emitting element;
  - converting the first time at which the light-emitting element is exposed to the environmental temperature into a third time at which the light-emitting element is exposed to a reference temperature to obtain a second reference stress amount equivalent to the temperature stress amount on the light-emitting element under the environmental temperature, and calculating an accumulated second reference stress

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amount obtained by accumulating the second reference stress amount resulting from the conversion; and  
 updating the efficiency residual ratio, using the accumulated first reference stress amount and the accumulated second reference stress amount that were calculated. 5

7. The method according to claim 6, wherein the efficiency residual ratio is expressed by a ratio of a light emission luminance of the light-emitting element after deterioration to a light emission luminance of the light-emitting element at an initial stage of operation, and 10

the updating of the efficiency residual ratio includes:  
 calculating, using a relationship between a luminance of the light-emitting element and an accumulated time for which the reference current flows through the light-emitting element, a first efficiency residual ratio that is new and attributable to current stress, from the accumulated time which is calculated as the accumulated first reference stress amount; 15  
 calculating, using a relationship between the luminance of the light-emitting element and an accumulated time for which the light-emitting element is exposed to the environmental temperature, a second efficiency residual ratio that is new and attributable to temperature stress; and 20  
 updating the efficiency residual ratio by calculating an updated efficiency residual ratio from the first efficiency residual ratio and the second efficiency residual ratio. 25

8. The method according to claim 6, wherein the current stress amount calculated from the corrected luminance value is a stress amount for a first current that flows through the light-emitting element when the light-emitting element is caused to emit light according to the corrected luminance value, 30  
 the stress amount for the first current is equivalent to the first time for which the first current flows through the light-emitting element, 35

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a stress amount for the reference current is equivalent to the second time for which the reference current flows through the light-emitting element, and  
 the converting of the current stress includes:  
 converting the current stress amount calculated from the corrected luminance value into the first reference stress amount by converting the first time for which the first current flows through the light-emitting element into the second time for which the reference current flows through the light-emitting element.

9. The method according to claim 6, wherein the temperature stress amount on the light-emitting element under the environmental temperature is a stress amount on the light-emitting element exposed to the environmental temperature,  
 the stress amount on the light-emitting element exposed to the environmental temperature is equivalent to the first time for which the light-emitting element is exposed to the environmental temperature,  
 the temperature stress amount on the light-emitting element under the reference temperature is equivalent to the third time for which the light-emitting element is exposed to the reference temperature, and  
 the converting of the temperature stress amount includes:  
 converting the temperature stress amount on the light-emitting element under the environmental temperature into the second reference stress amount by converting the first time for which the light-emitting element is exposed to the environmental temperature into the third time for which the light-emitting element is exposed to the reference temperature.

10. The method according to claim 6, wherein the environmental temperature of the pixel is a temperature of the pixel when a voltage corresponding to the output gradation value is applied to the light-emitting element.

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